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PATENT NUMBER and ISSUE DATE

U.S. UTILITY Patent Application

APPL NUM 10075465	FILING DATE 02/15/2002	CLASS 438	SUBCLASS 149	GAU 7.921 281.	EXAMINER GE YER	-
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	PPLICATIONS VE	RIFIED:				i
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oreign priority clair		⊒ yes ⊒ yes			ATTO:RNEY DOCKET NO	
Verified and Acknow	vledged Examiners's in	tials			219660US2S	
FITLE: Semiconductor device having patterned SOI structure and method for fabricating the same U.S.DEPT. OF COMM.PAT.2 TM-PTO-435L(Rev. 12-94)						
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NOTICE OF ALLOWANCE MAILED Assistant Examiner			CLAIMS ALLOWED			
		Assistant Examiner	Total Claims		Print Claim for D.G	
ISS	ISSUE FEE DRAW		DRAWING	3		
Amount Due	Date Paid		Sheets Drwg.	Figs.Drw	g. Print Fig.	
		Primary Examiner			<u> </u>	
TERMINAL		PREPARED FOR ISSUE	Application Examiner			
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